

Notice of References Cited

Application/Control No.

10/586,319

Applicant(s)/Patent Under
Reexamination
INOUE, MIKIO

Examiner

CHARLES V. HICKS

Art Unit

2629

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0019325	09-2001	Takekawa, Kenichi	345/157
	B	US-			
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FOREIGN PATENT DOCUMENTS

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